

<b>Notice of References Cited</b>	Application/Control No. 10/736,229		Applicant(s)/Patent Under Reexamination MATSUYAMA, SHIGERU	
	Examiner Kimnhung Nguyen		Art Unit 2629	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,791,539	09-2004	Nakajima et al.	345/204
*	B	US-2001/0043187	11-2001	Ikeda, Naoyasu	345/100
*	C	US-6,304,241	10-2001	Udo et al.	345/96
*	D	US-6,747,641	06-2004	Nakamura et al.	345/213
*	E	US-2002/0063674	05-2002	Chiang, Johnson	345/98
*	F	US-6,104,370	08-2000	Nakagaki et al.	345/100
*	G	US-6,876,365	04-2005	Tsutsui et al.	345/536
*	H	US-2002/0063676	05-2002	Murade et al.	345/100
*	I	US-6,795,051	09-2004	Ikeda, Naoyasu	345/100
*	J	US-6,940,479	09-2005	Kanbe et al.	345/87
*	K	US-6,462,725	10-2002	Orisaka, Yukihisa	345/98
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.